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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/779,812	02/08/2001	Sudipta K. Ray	END920010002US1	5588
5409 75	590 11/20/2002			
ARLEN L. OLSEN			EXAMINER	
SCHMEISER, OLSEN & WATTS 3 LEAR JET LANE			NGUYEN, HA T	
SUITE 201 LATHAM, NY 12110			ART UNIT	PAPER NUMBER
LATHAM, NY	12110		2812	14
			DATE MAILED: 11/20/2002	

Please find below and/or attached an Office communication concerning this application or proceeding.

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		Application No.	Applicant(s)			
•		09/779,812	RAY ET AL.			
Office Action Summary		Examiner	Art Unit			
		Ha T. Nguyen	2812			
Period f r	The MAILING DATE of this commu Reply	unication appears on the cover s	heet with the correspondence a	ddress		
THE MA - Extension after SIX - If the per - If NO pe - Failure to - Any reply	RTENED STATUTORY PERIOD ALLING DATE OF THIS COMMULATION OF THIS COMMULATION OF THIS COMMULATION OF THIS FOR THIS COMMULATION OF THIS FOR T	NICATION. ons of 37 CFR 1.136(a). In no event, however mmunication. r (30) days, a reply within the statutory minim statutory period will apply and will expire SI ply will, by statute, cause the application to b as after the mailing date of this communication	er, may a reply be timely filed um of thirty (30) days will be considered time K (6) MONTHS from the mailing date of this ecome ABANDONED (35 U.S.C. § 133).			
1)⊠ F	Responsive to communication(s)	filed on 09 September 2002.				
2a) <u> </u>	his action is FINAL .	2b)⊠ This action is non-fina	al.			
	Since this application is in conditi			he merits is		
Disposition	losed in accordance with the pra of Claims	actice under <i>Ex parte Quayle</i> , 1	935 C.D. 11, 453 O.G. 213.			
4)⊠ C	aim(s) <u>1-10 and 12-36</u> is/are pe	ending in the application.				
4a) Of the above claim(s) is	/are withdrawn from considerat	ion.			
5)□ C	aim(s) is/are allowed.					
6)⊠ C	aim(s) <u>1-10 and 12-36</u> is/are rej	ected.				
7)□ C	aim(s) is/are objected to.					
•—	aim(s) are subject to rest	riction and/or election requirem	ent.			
Application	-					
<i>'</i> —	e specification is objected to by					
•	e drawing(s) filed on is/ar					
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a). 11) The proposed drawing correction filed on is: a) approved b) disapproved by the Examiner.						
,	-			ner.		
If approved, corrected drawings are required in reply to this Office action.						
·—	e oath or declaration is objected	to by the Examiner.				
_	der 35 U.S.C. §§ 119 and 120					
, -	cknowledgment is made of a cla	• • • • • • • • • • • • • • • • • • • •	U.S.C. § 119(a)-(d) or (f).			
•—	All b)☐ Some * c)☐ None of					
	Certified copies of the priori	•				
	Certified copies of the priori					
	Copies of the certified copie application from the Inte the attached detailed Office ac	ernational Bureau (PCT Rule 17	′.2(a)).	i Stage		
14) 🔲 Acl	knowledgment is made of a clain	n for domestic priority under 35	U.S.C. § 119(e) (to a provision	al application).		
, -	☐ The translation of the foreign liknowledgment is made of a clair					
Attachment(s)					
2) L Notice of	of References Cited (PTO-892)	/ (PTO-948)	Notice of Informal Patent Application (P	o(s) TO-152)		
U.S. Patent and Trade	emark Office					



Art Unit: 2812

DETAILED ACTION

Notice to applicant

1. Applicants' Amendment and Response to the Office Action mailed 6-14-02 has been entered and made of record (Paper No. 12).

Response to Amendment

2. In view of Applicants' arguments and the amendment to the claims, the objections of claims 25 and 29 for informalities has been withdrawn.

In view of Applicants' arguments and the amendment to the claims, the rejections of claims 25-29 under 35 U.S.C. 112 second paragraph, as being indefinite, has been withdrawn.

In view of new art found and new interpretation of the references and the claims, the objection of claims 4 and 26 and the allowability of claims 7-10, 12-19, 24, 30, 32, and 34 have been withdrawn.

Applicants are referred to the new ground of rejection given below.

Claim Rejections - 35 USC § 112

3. Claims 35 and 36 are rejected under 35 U.S.C. 112, first paragraph, because the specification, while being enabling for a solder including about 3% to about 15% antimony by weight (see page 3, line 14), does not reasonably provide enablement for "more than 10% antimony by weight". The specification does not enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to use the invention commensurate in scope with these claims. The claimed range "more than 10% antimony by weight" covers up to 100% of antimony.

Claim Rejections - 35 USC § 102

- 4. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:
 - A person shall be entitled to a patent unless --
 - (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 5. Claims 1-3, 6, 20, 21, 23, 31, and 33 are rejected under 35 U.S.C. 102(b) as being anticipated by Ogashiwa, Australian Patent AU-B-68124/90.



Art Unit: 2812

[Claims 1, 2, 20, and 21] Referring to Figs. 1-5 and related text, discloses Ogashiwa discloses a method for forming an electronic structure and inherently the structure formed by the method, the method comprising the steps of providing a substrate 2a, 2; and soldering a lead-fee solder member 3a to the substrate without using a joining solder to effectuate the soldering (see page 4, lines 13-25), wherein the solder member comprises a tin-antimony alloy that includes predominantly Sn and about 5 to about 10 % Sb by weight (See Summary, Table 25, sample 2);

[Claims 3, 6, and 23] wherein the soldering step includes inherently reflowing the solder member to make it flow and adhere to the substrate; wherein the substrate includes a semiconductor chip 2 (see page 4, lines 13-25);

[Claims 31 and 33] wherein the solder member is a solder ball (See Figs. 2 and 3).

Claim Rejections - 35 USC § 103

- 6. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103© and potential 35 U.S.C. 102(f) or (g) prior art under 35 U.S.C. 103(a).

7. Claims 1-3, 6, 20, 21, 23, 35, and 36 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yamamoto et al. (EP 0544915 A1, hereinafter "Yamamoto").

[Claims 1, 2, 20, 21, 35, and 36] Referring to Figs. 4A-8 and related text, discloses Yamamoto discloses a method for forming an electronic structure and inherently the structure formed by the method, the method comprising the steps of providing a substrate 50; and



Art Unit: 2812

soldering a lead-fee solder member to the substrate without using a joining solder to effectuate the soldering (see page 5, lines 5-14), wherein the solder member comprises a tin-antimony alloy that includes predominantly Sn and about 15 % or less by weight of Sb (See page 7, lines 24-28). But it does not disclose expressly the claimed range. However, in the case where the claimed range "overlap or lie inside ranges disclosed by the prior art" a prima facie case of obviousness exists (See MPEP 2144.05).

[Claims 3, 6, and 23] Yamamoto also discloses wherein the soldering step includes reflowing the solder member to adhere it to the substrate (see page 5, lines 5-14 and page 8, lines 2-5); wherein the substrate includes a semiconductor chip 2 (see page 7, lines 10-17).

Therefore, it would have been obvious to use Yamamoto's teaching to obtain the invention as specified in claims 1-3, 6, 20, 21, 23, 35, and 36.

7. Claim 4 is rejected under 35 U.S.C. 103(a) as being unpatentable over Yamamoto or Ogashiwa, as applied above, and in view of Gundotra et al. (US Patent 5369880, hereinafter "Gundotra").

Yamamoto or Ogashiwa discloses substantially the limitations of claim 4, as shown above.

But it does not disclose expressly wherein the soldering step reduces a height of the solder member between about 25% and about 30%.

However, the missing limitation is well known in the art because Gundotra discloses that this range of height reduction is commonly achieved in the art (see col. 3, lines 53-58).

A person of ordinary skill is motivated to modify Yamamoto or Ogashiwa with Gundotra to obtain the desired height reduction appropriate for a specific application.

Therefore, it would have been obvious to combine Yamamoto or Ogashiwa with Gundotra to obtain the invention as specified in claim 4.

8. Claims 7-10, 12-19, 24-28, 30, 32, and 34 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yamamoto, in view of Yamashita et al. (US Patent 6179935, hereinafter "Yamashita").



Art Unit: 2812

[Claims 7, 12, 24, and 28] The argument used for the rejection of claims 1-3, 6, 20, 21, 23, 35, and 36 also apply. Yamamoto also discloses providing a second substrate 80 and soldering the solder member to a second substrate with a joiner solder 84 (see Fig. 12). But it does not disclose expressly that the joiner solder is lead-free comprising Sn-Ag-Cu alloy with the claimed percentage of Ag and Cu. However, the missing limitations are well known in the art because Yamashita discloses these features (see par. bridging cols. 9 and 10). A person of ordinary skill is motivated to modify Yamamoto with Yamashita to obtain the connection of desired characteristics appropriate for a specific application.

[Claims 8, 19, 25, and 30] The argument used for the rejection of claims 1-3, 6, 20, 21, 23, 35, and 36 also apply.

[Claims 9, 16, 17, and 27] Yamamoto also discloses wherein the step of soldering the solder member to the second substrate includes reflowing the joiner solder at a temperature above a liquidus temperature of the joiner solder and below a highest temperature which will not damage any portion of the electronic structure; wherein the step of soldering the solder member to the second substrate does not include melting the solder member; and wherein the step of soldering the solder member to the second substrate does not include intermixing the solder member material with the joiner solder (see page 11, lines 14-31);

[Claims 10,13-15, and 26] Yamamot discloses the melting point of solder member to be about 240 to 330C (see page 4, last par.) and Yamashita discloses Sn-Ag solder melts at about 221C (see col.10, lines 18-30). It would have been obvious to reflow the joiner solder in the range of about 230-250C, temperature only high enough to reflow joiner solder. In the situation where it is desirable to have solder member having a melting temperature in the lower range discloses by Yamamoto, it would have been obvious for a person of ordinary skill in the art to have the solder member melt and intermix with the joiner solder to form even better bond.

[Claims 32 and 34] The combined teaching of Yamamoto and Yamashita discloses substantially the limitations of claims 32 and 34, as shown above. But it does not disclose wherein the solder member is a solder ball. However, solder balls are commonly used for soldering.

Therefore, it would have been obvious to combine Yamamoto with Yamashita to obtain the invention as specified in claims 7-10, 12-19, 24-28, 30, 32, and 34.



Art Unit: 2812

9. Claims 5, 18, 22, and 29 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yamamoto, Ogashiwa, or Yamamoto and Yamashita, in view of Behlen et al. (US Patent 5598033, hereinafter "Behlen").

Yamamoto, Ogashiwa, or Yamamoto and Yamashita discloses substantially the limitations of claims 5, 18, 22, and 29 as shown above.

But it does not disclose expressly wherein the substrate includes a ceramic ball grid array (CBGA) module or a plastic ball grid array (PBGA) module.

However, the missing limitation is well known in the art because Behlen discloses CBGA and PGCA are common type of electronic package (See col. 1, lines 22-33).

A person of ordinary skill is motivated to modify Yamamoto, Ogashiwa, or Yamamoto and Yamashita with Behlen to obtain the desired package appropriate for a specific application.

Therefore, it would have been obvious to combine Yamamoto, Ogashiwa, or Yamamoto and Yamashita with Behlen to obtain the invention as specified in claims 5, 18, 22, and 29.

Conclusion

10. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Ha Nguyen whose telephone number is (703)308-2706. The examiner can normally be reached on Monday-Friday from 8:30AM to 6:00PM, except the first Friday of each bi-week.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Neibling, can be reached on (703) 308-3325. The fax phone number for this Group is (703) 308-7722.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the Group receptionist whose telephone number is (703) 308-0956.

Ha Nguyen

Primary Examiner

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